

Applic	ation	No.

10/017,680

Examiner

Maikhanh Nguyen

Applicant(s)

LUCOVSKY ET AL.
Art Unit

2176

SEARCHED				
Class	Subclass	Date	Examiner	
715	501.1	1/18/2005	мк	
·	513	1/18/2005	MK	
707	10	1/18/2005	MK	
709	203	1/18/2005	MK	
	217	1/18/2005	MK	
	229	1/18/2005	MK	
Updated	Search	7/6/2005	MK	
Updated	Search	3/23/2006	MK	
Updated	Search	2/4/2007	MK	
Updated	Search	7/31/2007	MK	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
715	500	7/31/2007	MK		
	501.1 513	7/31/2007	мк		
707	10	7/31/2007	MK		
709	203 217	7/31/2007	МК		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
West search	1/18/2005	МК		
West Search	1/19/2005	МК		
NPL(IEEE)	1/19/2005	MK		
West Updated (Updated Search enclosed)	7/6/2005	МК		
West Updated (see Search History)	3/23/2006	МК		
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	2/4/2007	МК		
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	7/31/2007	MK		
Interference Search	8/1/2007	МК		